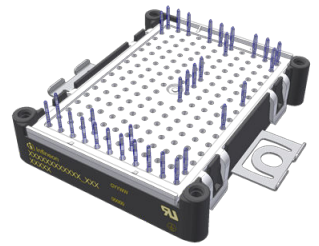


Preliminary datasheet

EasyPACK™ 模块 采用 CoolSiC™ Trench MOSFET 带有 PressFIT 压接管脚和温度检测 NTC

特性

- 电气特性
 - $V_{DS} = 1200\text{ V}$
 - $I_{DN} = 75\text{ A} / I_{DRM} = 150\text{ A}$
 - 低电感设计
 - 低开关损耗
 - 高电流密度
 - 可以从下面链接寻找适合的英飞凌驱动 IC <https://www.infineon.com/gdfinder>
- 机械特性
 - PressFIT 压接技术
 - 集成 NTC 温度传感器
 - 集成的安装夹使安装坚固
 - 封装的 CTI > 600
 - 高电流压接管脚



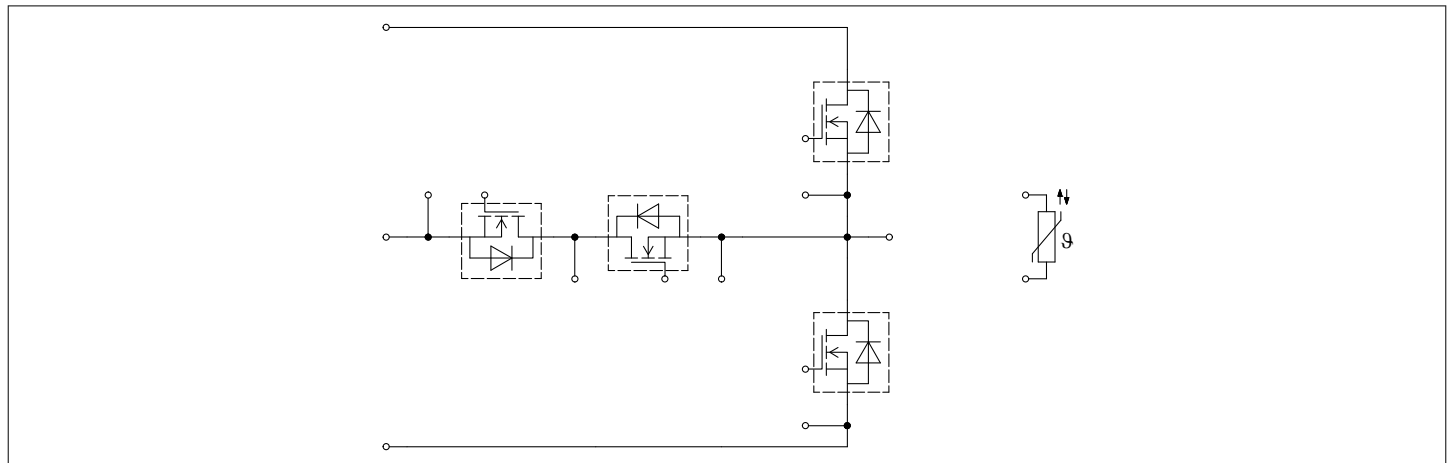
可选应用

- 高频开关应用
- DC/DC 变换器
- 电动车直流充电

产品认证

- 根据 IEC 60747、60749 和 60068 标准的相关测试，符合工业应用的要求。

描述





内容

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1 封装

表 1 绝缘参数

特征参数	代号	标注或测试条件	数值	单位
绝缘测试电压	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.0	kV
NTC 绝缘测试电压	$V_{ISOL(NTC)}$	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.0	kV
内部绝缘		基本绝缘 (class 1, IEC 61140)	Al_2O_3	
相对电痕指数	CTI		> 600	
相对温度指数 (电)	RTI	基壳	130	°C
		上盖	130	

表 2 特征值

特征参数	代号	标注或测试条件	数值			单位
			最小值	典型值	最大值	
杂散电感, 模块	L_{sCE}			19		nH
模块引线电阻, 端子-芯片	$R_{CC'+EE'}$	$T_H = 25 \text{ °C}$, 每个开关		2.6		mΩ
储存温度	T_{stg}		-40		130	°C
Mounting force per clamp	F		40		80	N
重量	G			38		g

注: The current under continuous operation is limited to 50 A rms per connector pin.

2 MOSFET, T1 / T2

表 3 最大标定值

特征参数	代号	标注或测试条件		数值	单位
漏源极电压	V_{DSS}		$T_{vj} = 25 \text{ °C}$	1200	V
植入漏极电流	I_{DN}			75	A
连续漏极直流电流	I_{DDC}	$T_{vj} = 175 \text{ °C}$, $V_{GS} = 18 \text{ V}$	$T_H = 25 \text{ °C}$	95	A
漏极重复峰值电流	I_{DRM}	verified by design, t_p limited by T_{vjmax}		150	A
栅-源瞬态最大电压	V_{GS}	$D < 0.01$		-10/25	V
栅-源稳态最大电压	V_{GS}			-7/20	V

表 4 推荐值

特征参数	代号	标注或测试条件	[ZH]Values	单位
通态栅极电压	$V_{GS(on)}$		15...18	V
断态栅极电压	$V_{GS(off)}$		-5...0	V

表 5 特征值

特征参数	代号	标注或测试条件		数值			单位
				最小值	典型值	最大值	
漏源通态电阻	$R_{DS(on)}$	$I_D = 75\text{ A}$	$V_{GS} = 18\text{ V}, T_{vj} = 25\text{ °C}$		8.3		$\text{m}\Omega$
			$V_{GS} = 18\text{ V}, T_{vj} = 125\text{ °C}$		13		
			$V_{GS} = 18\text{ V}, T_{vj} = 175\text{ °C}$		16.8		
			$V_{GS} = 15\text{ V}, T_{vj} = 25\text{ °C}$		10		
栅极阈值电压	$V_{GS(th)}$	$I_D = 33\text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25\text{ °C}, (\text{tested after } 1\text{ms pulse at } V_{GS} = +20\text{ V}), T_{vj} = 25\text{ °C}$		3.45	4.3	5.15	V
栅极电荷	Q_G	$V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, T_{vj} = 25\text{ °C}$			0.237		μC
内部栅极电阻	R_{Gint}	$T_{vj} = 25\text{ °C}$			3.5		Ω
输入电容	C_{ISS}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		7.21		nF
输出电容	C_{OSS}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.293		nF
反向传输电容	C_{rss}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.02		nF
C_{OSS} 存储能量	E_{OSS}	$V_{DS} = 800\text{ V}, V_{GS} = -3/18\text{ V}, T_{vj} = 25\text{ °C}$			121		μJ
漏源泄漏电流	I_{DSS}	$V_{DS} = 1200\text{ V}, V_{GS} = -3\text{ V}$	$T_{vj} = 25\text{ °C}$		0.3	296	μA
栅极漏电流	I_{GSS}	$V_{DS} = 0\text{ V}, T_{vj} = 25\text{ °C}$	$V_{GS} = 20\text{ V}$			400	nA
开通延迟时间(感性负载)	$t_{d on}$	$I_D = 75\text{ A}, R_{Gon} = 10\text{ }\Omega, V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, t_{dead} = 1000\text{ ns}, 0.1 V_{GS} \text{ to } 0.1 I_D$	$T_{vj} = 25\text{ °C}$		50.4		ns
			$T_{vj} = 125\text{ °C}$		45.7		
			$T_{vj} = 175\text{ °C}$		43.8		
上升时间(感性负载)	t_r	$I_D = 75\text{ A}, R_{Gon} = 10\text{ }\Omega, V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, t_{dead} = 1000\text{ ns}, 0.1 I_D \text{ to } 0.9 I_D$	$T_{vj} = 25\text{ °C}$		24.5		ns
			$T_{vj} = 125\text{ °C}$		22.1		
			$T_{vj} = 175\text{ °C}$		21.5		
关断延迟时间(感性负载)	$t_{d off}$	$I_D = 75\text{ A}, R_{Goff} = 2.7\text{ }\Omega, V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, 0.9 V_{GS} \text{ to } 0.9 I_D$	$T_{vj} = 25\text{ °C}$		63		ns
			$T_{vj} = 125\text{ °C}$		71.4		
			$T_{vj} = 175\text{ °C}$		76.4		

(待续)

表 5 (续) 特征值

特征参数	代号	标注或测试条件	数值			单位
			最小值	典型值	最大值	
下降时间(感性负载)	t_f	$I_D = 75\text{ A}$, $R_{Goff} = 2.7\ \Omega$, $V_{DD} = 800\text{ V}$, $V_{GS} = -3/18\text{ V}$, $0.9 I_D$ to $0.1 I_D$	$T_{vj} = 25\text{ }^\circ\text{C}$	28.7		ns
			$T_{vj} = 125\text{ }^\circ\text{C}$	31		
			$T_{vj} = 175\text{ }^\circ\text{C}$	32.5		
开通损耗能量 (每脉冲)	E_{on}	$I_D = 75\text{ A}$, $V_{DD} = 800\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Gon} = 10\ \Omega$, $di/dt = 4.11\text{ kA}/\mu\text{s}$ ($T_{vj} = 175\text{ }^\circ\text{C}$), $t_{dead} = 1000\text{ ns}$	$T_{vj} = 25\text{ }^\circ\text{C}$	2.57		mJ
			$T_{vj} = 125\text{ }^\circ\text{C}$	2.74		
			$T_{vj} = 175\text{ }^\circ\text{C}$	2.94		
开通损耗能量 (每脉冲), 优化条件下	$E_{on,o}$	$I_D = 75\text{ A}$, $V_{DD} = 800\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Gon,o} = 1\ \Omega$, $di/dt = 10.6\text{ kA}/\mu\text{s}$ ($T_{vj} = 175\text{ }^\circ\text{C}$), $t_{dead} = 100\text{ ns}$	$T_{vj} = 25\text{ }^\circ\text{C}$	1.01		mJ
			$T_{vj} = 125\text{ }^\circ\text{C}$	1.11		
			$T_{vj} = 175\text{ }^\circ\text{C}$	1.27		
关断损耗能量 (每脉冲)	E_{off}	$I_D = 75\text{ A}$, $V_{DD} = 800\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Goff} = 2.7\ \Omega$, $dv/dt = 28.2\text{ kV}/\mu\text{s}$ ($T_{vj} = 175\text{ }^\circ\text{C}$)	$T_{vj} = 25\text{ }^\circ\text{C}$	0.8		mJ
			$T_{vj} = 125\text{ }^\circ\text{C}$	0.86		
			$T_{vj} = 175\text{ }^\circ\text{C}$	0.91		
结-散热器热阻	R_{thJH}	每个 MOSFET, $\lambda_{grease} = 5\text{ W}/(\text{m}\cdot\text{K})$		0.635		K/W
允许开关的温度范围	$T_{vj\text{ op}}$		-40		175	$^\circ\text{C}$
过载运行条件下的温度	$T_{vj\text{ over}}$	过载工况, 累计最大 100 小时			200	$^\circ\text{C}$

注: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2025-02 must be considered to ensure sound operation of the device over the planned lifetime.

3 Body diode (MOSFET, T1 / T2)

表 6 最大标定值

特征参数	代号	标注或测试条件	数值	单位
体二极管正向直流电流	I_{SD}	$T_{vj} = 175\text{ }^\circ\text{C}$, $V_{GS} = -3\text{ V}$ $T_H = 25\text{ }^\circ\text{C}$	50	A

表 7 特征值

特征参数	代号	标注或测试条件	数值			单位
			最小值	典型值	最大值	
正向电压	V_{SD}	$I_{SD} = 75 \text{ A}$, $V_{GS} = -3 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	4.35	5.35	V
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	4.05		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	3.9		
反向恢复峰值电流	I_{rrm}	$I_{SD} = 75 \text{ A}$, $di_s/dt = 4.11 \text{ kA}/\mu\text{s}$, $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	35.2		A
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	50		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	61.5		
恢复电荷	Q_{rr}	$I_{SD} = 75 \text{ A}$, $di_s/dt = 4.11 \text{ kA}/\mu\text{s}$, $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	0.51		μC
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	1.12		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	1.59		
反向恢复损耗（每脉冲）	E_{rec}	$I_{SD} = 75 \text{ A}$, $di_s/dt = 4.11 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175 \text{ }^{\circ}\text{C}$), $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	0.13		mJ
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	0.34		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	0.5		
反向恢复损耗（每脉冲）， 优化条件下	$E_{rec,o}$	$I_{SD} = 75 \text{ A}$, $di_s/dt = 10.6 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175 \text{ }^{\circ}\text{C}$), $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 100 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	0.89		mJ
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	1.73		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	2.6		

4 MOSFET, T3 / T4

表 8 最大标定值

特征参数	代号	标注或测试条件	数值	单位
漏源极电压	V_{DSS}	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	1200	V
植入漏极电流	I_{DN}		75	A
连续漏极直流电流	I_{DDC}	$T_{vj} = 175 \text{ }^{\circ}\text{C}$, $V_{GS} = 18 \text{ V}$ $T_H = 25 \text{ }^{\circ}\text{C}$	85	A
漏极重复峰值电流	I_{DRM}	verified by design, t_p limited by T_{vjmax}	150	A
栅-源瞬态最大电压	V_{GS}	$D < 0.01$	-10/25	V
栅-源稳态最大电压	V_{GS}		-7/20	V

表 9 推荐值

特征参数	代号	标注或测试条件	[ZH]Values	单位
通态栅极电压	$V_{GS(on)}$		15...18	V
断态栅极电压	$V_{GS(off)}$		-5...0	V

表 10 特征值

特征参数	代号	标注或测试条件		数值			单位
				最小值	典型值	最大值	
漏源通态电阻	$R_{DS(on)}$	$I_D = 75\text{ A}$	$V_{GS} = 18\text{ V}, T_{vj} = 25\text{ °C}$		8.3		$\text{m}\Omega$
			$V_{GS} = 18\text{ V}, T_{vj} = 125\text{ °C}$		13		
			$V_{GS} = 18\text{ V}, T_{vj} = 175\text{ °C}$		16.8		
			$V_{GS} = 15\text{ V}, T_{vj} = 25\text{ °C}$		10		
栅极阈值电压	$V_{GS(th)}$	$I_D = 33\text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25\text{ °C}, (\text{tested after } 1\text{ms pulse at } V_{GS} = +20\text{ V}), T_{vj} = 25\text{ °C}$		3.45	4.3	5.15	V
栅极电荷	Q_G	$V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, T_{vj} = 25\text{ °C}$			0.237		μC
内部栅极电阻	R_{Gint}	$T_{vj} = 25\text{ °C}$			3.5		Ω
输入电容	C_{ISS}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		7.21		nF
输出电容	C_{OSS}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.293		nF
反向传输电容	C_{rss}	$f = 100\text{ kHz}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.02		nF
C_{OSS} 存储能量	E_{OSS}	$V_{DS} = 800\text{ V}, V_{GS} = -3/18\text{ V}, T_{vj} = 25\text{ °C}$			121		μJ
漏源泄漏电流	I_{DSS}	$V_{DS} = 1200\text{ V}, V_{GS} = -3\text{ V}$	$T_{vj} = 25\text{ °C}$		0.3	296	μA
栅极漏电流	I_{GSS}	$V_{DS} = 0\text{ V}, T_{vj} = 25\text{ °C}$	$V_{GS} = 20\text{ V}$			400	nA
开通延迟时间(感性负载)	$t_{d on}$	$I_D = 75\text{ A}, R_{Gon} = 5.6\text{ }\Omega, V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, t_{dead} = 1000\text{ ns}, 0.1 V_{GS} \text{ to } 0.1 I_D$	$T_{vj} = 25\text{ °C}$		46		ns
			$T_{vj} = 125\text{ °C}$		42.9		
			$T_{vj} = 175\text{ °C}$		41.1		
上升时间(感性负载)	t_r	$I_D = 75\text{ A}, R_{Gon} = 5.6\text{ }\Omega, V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, t_{dead} = 1000\text{ ns}, 0.1 I_D \text{ to } 0.9 I_D$	$T_{vj} = 25\text{ °C}$		19.9		ns
			$T_{vj} = 125\text{ °C}$		17.8		
			$T_{vj} = 175\text{ °C}$		17.1		
关断延迟时间(感性负载)	$t_{d off}$	$I_D = 75\text{ A}, R_{Goff} = 2.7\text{ }\Omega, V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}, 0.9 V_{GS} \text{ to } 0.9 I_D$	$T_{vj} = 25\text{ °C}$		64.1		ns
			$T_{vj} = 125\text{ °C}$		73.5		
			$T_{vj} = 175\text{ °C}$		79.2		

(待续)

表 10 (续) 特征值

特征参数	代号	标注或测试条件	数值			单位
			最小值	典型值	最大值	
下降时间(感性负载)	t_f	$I_D = 75\text{ A}$, $R_{Goff} = 2.7\ \Omega$, $V_{DD} = 800\text{ V}$, $V_{GS} = -3/18\text{ V}$, $0.9\ I_D$ to $0.1\ I_D$	$T_{vj} = 25\text{ °C}$	30.7		ns
			$T_{vj} = 125\text{ °C}$	31.9		
			$T_{vj} = 175\text{ °C}$	32.3		
开通损耗能量 (每脉冲)	E_{on}	$I_D = 75\text{ A}$, $V_{DD} = 800\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Gon} = 5.6\ \Omega$, $di/dt = 4.95\text{ kA}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$), $t_{dead} = 1000\text{ ns}$	$T_{vj} = 25\text{ °C}$	2.02		mJ
			$T_{vj} = 125\text{ °C}$	2.19		
			$T_{vj} = 175\text{ °C}$	2.43		
开通损耗能量 (每脉冲), 优化条件下	$E_{on,o}$	$I_D = 75\text{ A}$, $V_{DD} = 800\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Gon,o} = 0.0\ \Omega$, $di/dt = 11.1\text{ kA}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$), $t_{dead} = 100\text{ ns}$	$T_{vj} = 25\text{ °C}$	0.81		mJ
			$T_{vj} = 125\text{ °C}$	0.85		
			$T_{vj} = 175\text{ °C}$	0.99		
关断损耗能量 (每脉冲)	E_{off}	$I_D = 75\text{ A}$, $V_{DD} = 800\text{ V}$, $L_\sigma = 15\text{ nH}$, $V_{GS} = -3/18\text{ V}$, $R_{Goff} = 2.7\ \Omega$, $dv/dt = 25.8\text{ kV}/\mu\text{s}$ ($T_{vj} = 175\text{ °C}$)	$T_{vj} = 25\text{ °C}$	0.83		mJ
			$T_{vj} = 125\text{ °C}$	0.92		
			$T_{vj} = 175\text{ °C}$	0.98		
结-散热器热阻	R_{thJH}	每个 MOSFET, $\lambda_{grease} = 5\text{ W}/(\text{m}\cdot\text{K})$		0.79		K/W
允许开关的温度范围	$T_{vj\text{ op}}$		-40		175	°C
过载运行条件下的温度	$T_{vj\text{ over}}$	过载工况, 累计最大 100 小时			200	°C

注: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2025-02 must be considered to ensure sound operation of the device over the planned lifetime.

5 Body diode (MOSFET, T3 / T4)

表 11 最大标定值

特征参数	代号	标注或测试条件	数值	单位
体二极管正向直流电流	I_{SD}	$T_{vj} = 175\text{ °C}$, $V_{GS} = -3\text{ V}$ $T_H = 25\text{ °C}$	40	A

表 12 特征值

特征参数	代号	标注或测试条件	数值			单位
			最小值	典型值	最大值	
正向电压	V_{SD}	$I_{SD} = 75 \text{ A}$, $V_{GS} = -3 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	4.35	5.35	V
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	4.05		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	3.9		
反向恢复峰值电流	I_{rrm}	$I_{SD} = 75 \text{ A}$, $di_s/dt = 4.95 \text{ kA}/\mu\text{s}$, $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	40.7		A
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	58.1		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	70.5		
恢复电荷	Q_{rr}	$I_{SD} = 75 \text{ A}$, $di_s/dt = 4.95 \text{ kA}/\mu\text{s}$, $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	0.55		μC
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	1.18		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	1.61		
反向恢复损耗（每脉冲）	E_{rec}	$I_{SD} = 75 \text{ A}$, $di_s/dt = 4.95 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175 \text{ }^{\circ}\text{C}$), $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 1000 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	0.14		mJ
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	0.37		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	0.49		
反向恢复损耗（每脉冲）， 优化条件下	$E_{rec,o}$	$I_{SD} = 75 \text{ A}$, $di_s/dt = 11.1 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175 \text{ }^{\circ}\text{C}$), $V_{DD} = 800 \text{ V}$, $V_{GS} = -3 \text{ V}$, $t_{dead} = 100 \text{ ns}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$	0.88		mJ
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$	1.47		
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$	1.92		

6 负温度系数热敏电阻

表 13 特征值

特征参数	代号	标注或测试条件	数值			单位
			最小值	典型值	最大值	
额定电阻值	R_{25}	$T_{NTC} = 25 \text{ }^{\circ}\text{C}$		5		$\text{k}\Omega$
R_{100} 偏差	$\Delta R/R$	$T_{NTC} = 100 \text{ }^{\circ}\text{C}$, $R_{100} = 493 \text{ }\Omega$	-5		5	%
耗散功率	P_{25}	$T_{NTC} = 25 \text{ }^{\circ}\text{C}$			20	mW
B-值	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-值	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-值	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

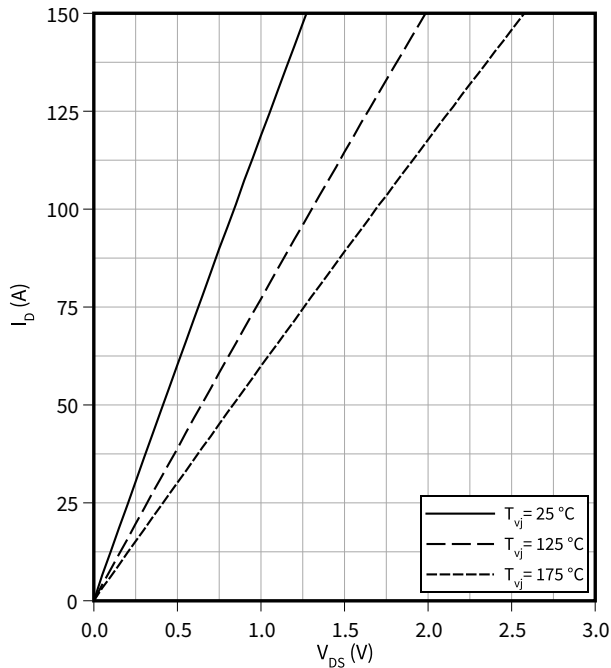
注: NTC 的具体参数分析请见 AN2009-10, 第 4 章

7 特征参数图表

输出特性（典型）, MOSFET, T1 / T2

$I_D = f(V_{DS})$

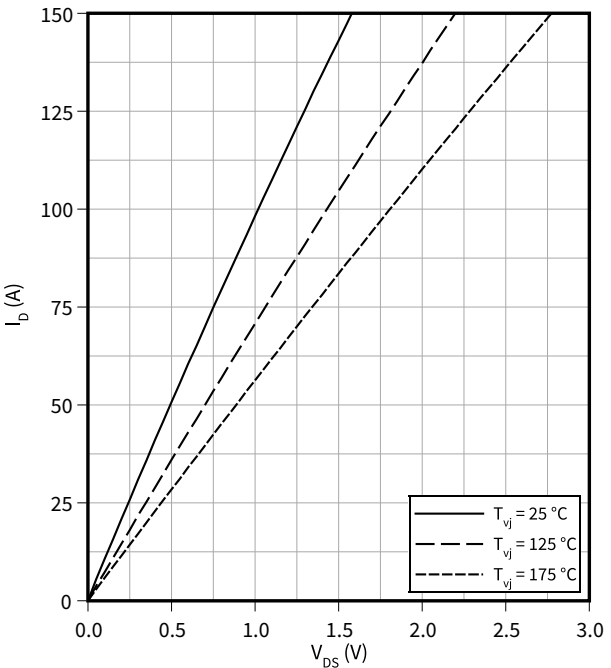
$V_{GS} = 18\text{ V}$



输出特性（典型）, MOSFET, T1 / T2

$I_D = f(V_{DS})$

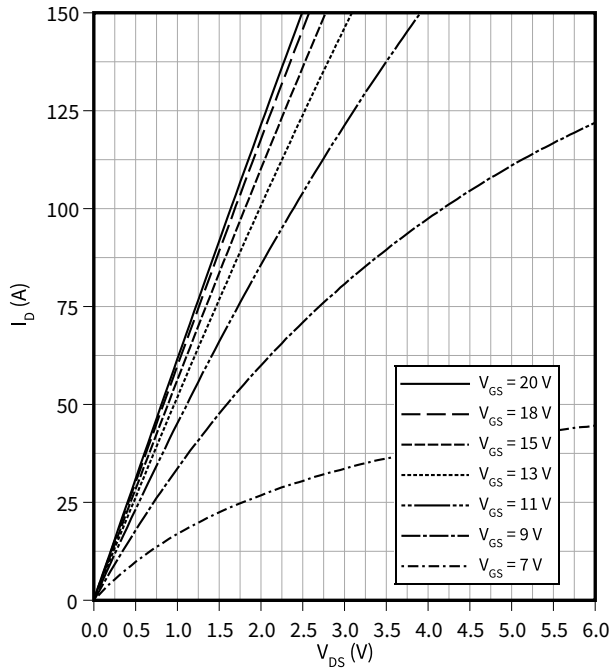
$V_{GS} = 15\text{ V}$



输出特性（典型）, MOSFET, T1 / T2

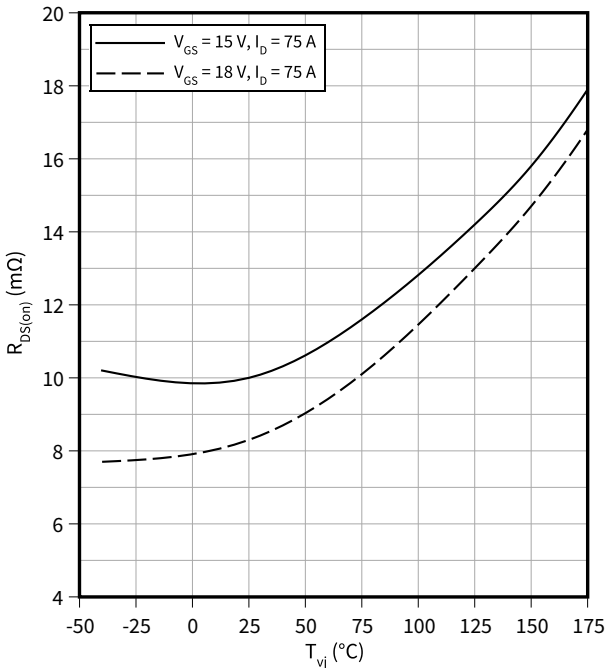
$I_D = f(V_{DS})$

$T_{vj} = 175\text{ °C}$



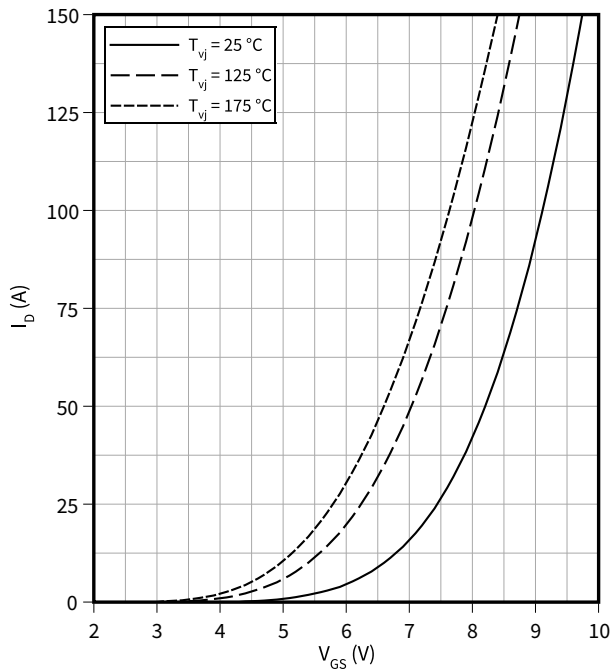
漏源通态电阻（典型）, MOSFET, T1 / T2

$R_{DS(on)} = f(T_{vj})$



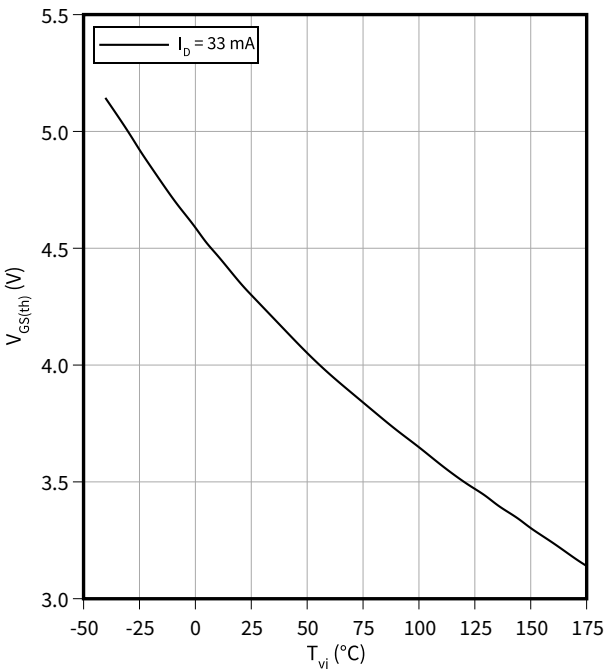
传输特性（典型）, MOSFET, T1 / T2

$I_D = f(V_{GS})$
 $V_{DS} = 20\text{ V}$



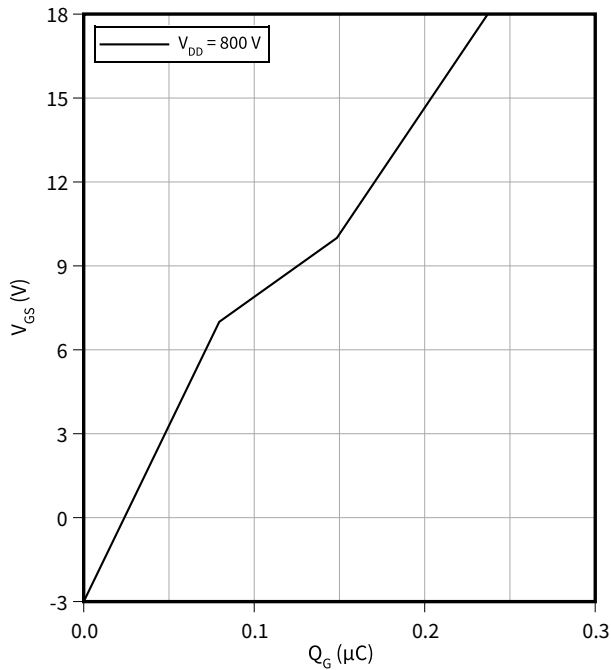
栅-源阈值电压（典型）, MOSFET, T1 / T2

$V_{GS(th)} = f(T_{vj})$
 $V_{GS} = V_{DS}$



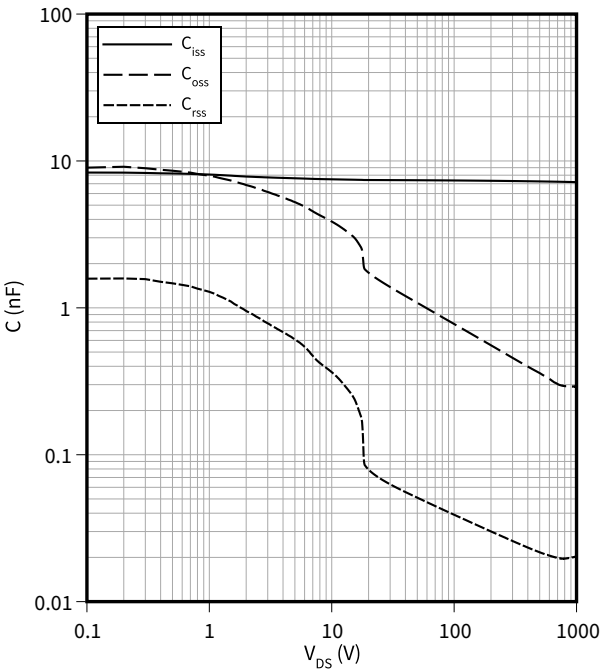
栅极电荷特性（典型）, MOSFET, T1 / T2

$V_{GS} = f(Q_G)$
 $I_D = 75\text{ A}, T_{vj} = 25\text{ °C}$



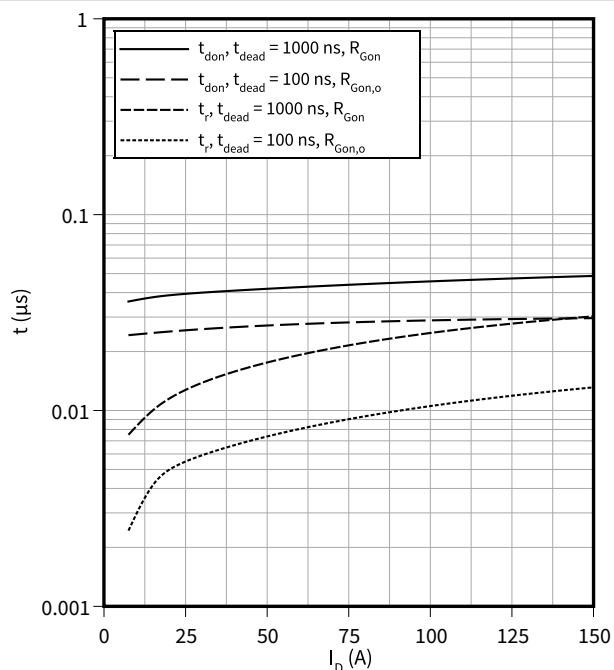
电容特性（典型）, MOSFET, T1 / T2

$C = f(V_{DS})$
 $f = 100\text{ kHz}, T_{vj} = 25\text{ °C}, V_{GS} = 0\text{ V}$



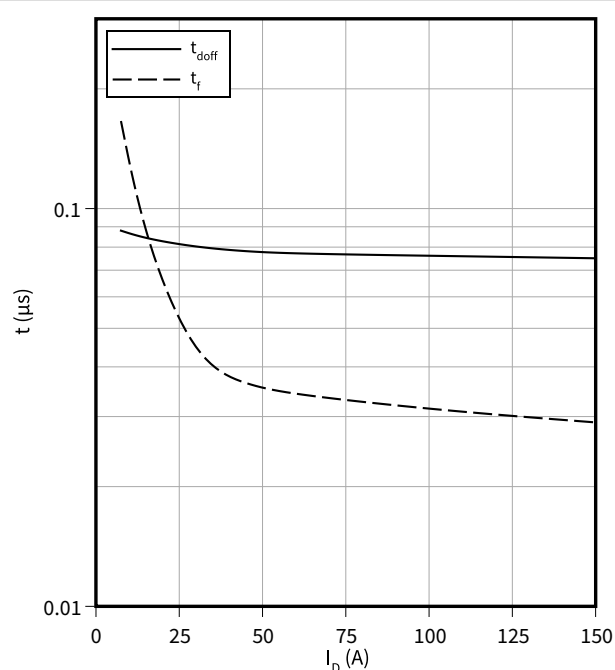
开关时间 (典型), MOSFET, T1 / T2

$$t = f(I_D)$$

 $V_{DD} = 800 \text{ V}, R_{Gon} = 10 \Omega, R_{Gon,o} = 1 \Omega, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GS} = -3/18 \text{ V}$


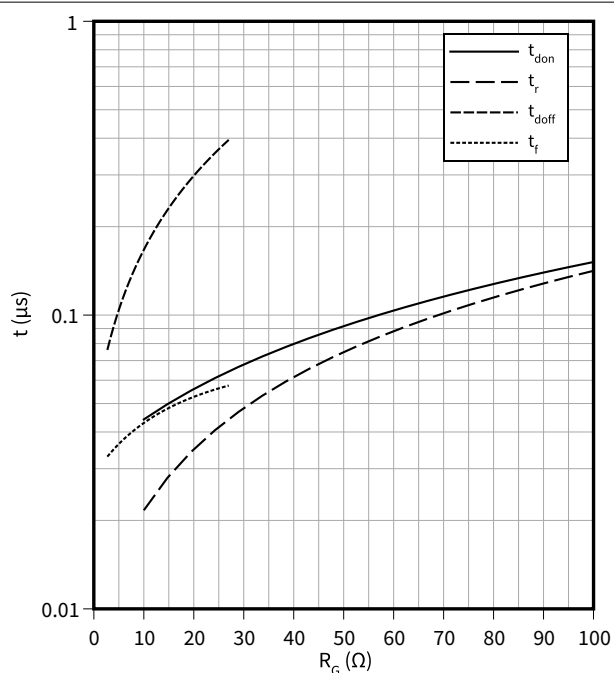
开关时间 (典型), MOSFET, T1 / T2

$$t = f(I_D)$$

 $R_{Goff} = 2.7 \Omega, V_{DD} = 800 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GS} = -3/18 \text{ V}$


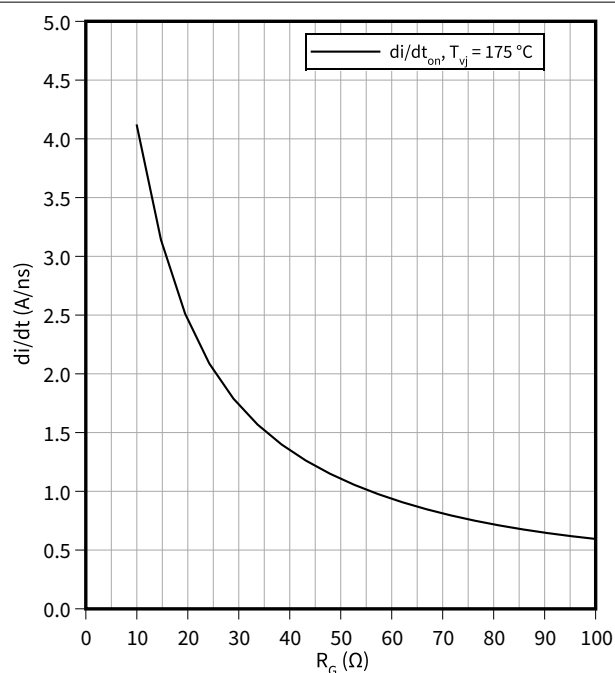
开关时间 (典型), MOSFET, T1 / T2

$$t = f(R_G)$$

 $V_{DD} = 800 \text{ V}, t_{dead} = 1000 \text{ ns}, I_D = 75 \text{ A}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GS} = -3/18 \text{ V}$


电流变化斜率 (典型), MOSFET, T1 / T2

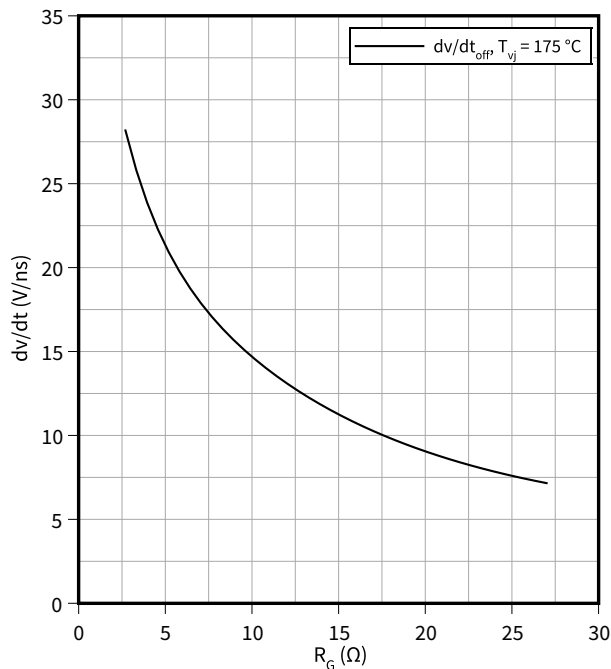
$$di/dt = f(R_G)$$

 $V_{DD} = 800 \text{ V}, t_{dead} = 1000 \text{ ns}, I_D = 75 \text{ A}, V_{GS} = -3/18 \text{ V}$


7 特征参数图表

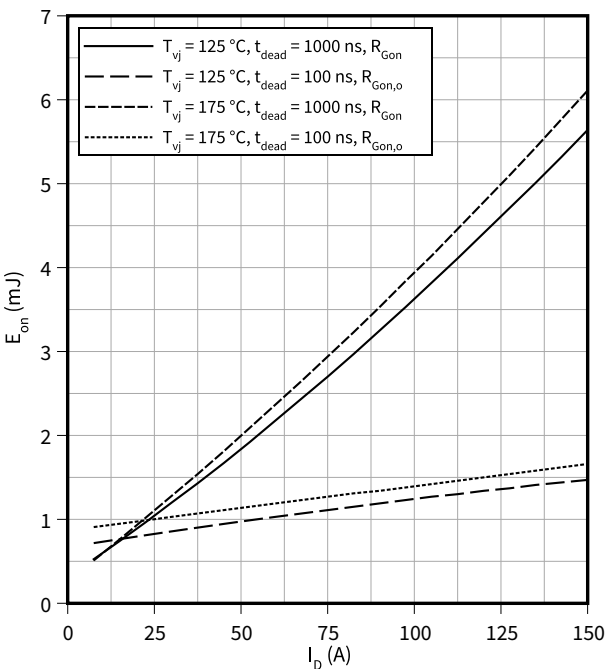
电压变化斜率（典型）, MOSFET, T1 / T2

$dv/dt = f(R_G)$
 $V_{DD} = 800\text{ V}$, $I_D = 75\text{ A}$, $V_{GS} = -3/18\text{ V}$



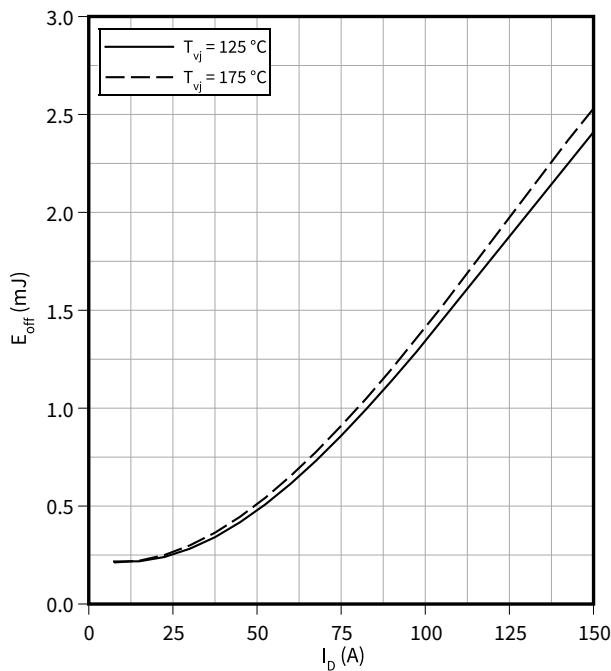
开关损耗（典型）, MOSFET, T1 / T2

$E_{on} = f(I_D)$
 $V_{DD} = 800\text{ V}$, $R_{Gon} = 10\text{ Ω}$, $R_{Gon,o} = 1\text{ Ω}$, $V_{GS} = -3/18\text{ V}$



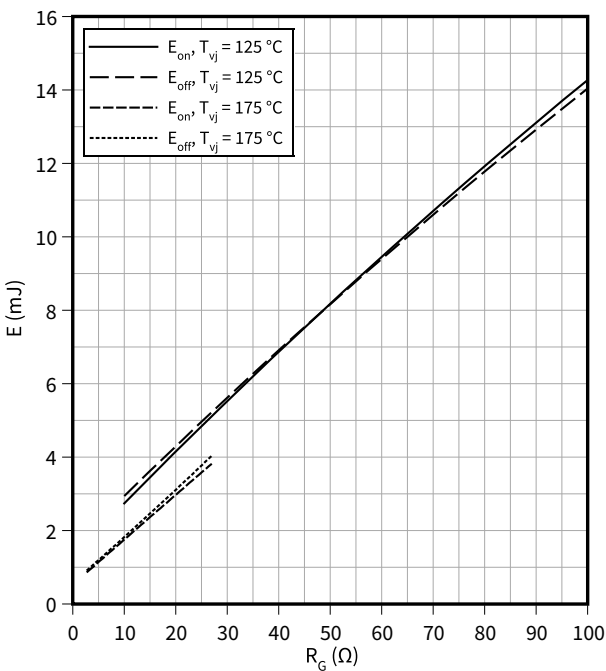
开关损耗（典型）, MOSFET, T1 / T2

$E_{off} = f(I_D)$
 $R_{Goff} = 2.7\text{ Ω}$, $V_{DD} = 800\text{ V}$, $V_{GS} = -3/18\text{ V}$



开关损耗（典型）, MOSFET, T1 / T2

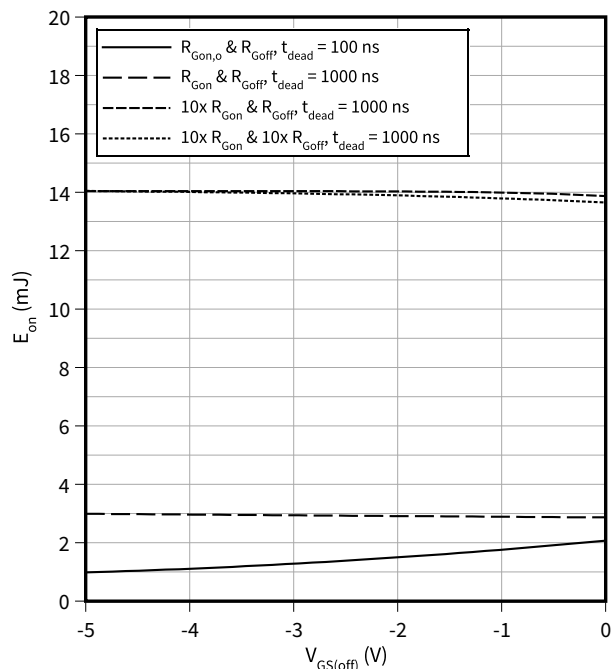
$E = f(R_G)$
 $V_{DD} = 800\text{ V}$, $t_{dead} = 1000\text{ ns}$, $I_D = 75\text{ A}$, $V_{GS} = -3/18\text{ V}$



开关损耗 (典型), MOSFET, T₁ / T₂

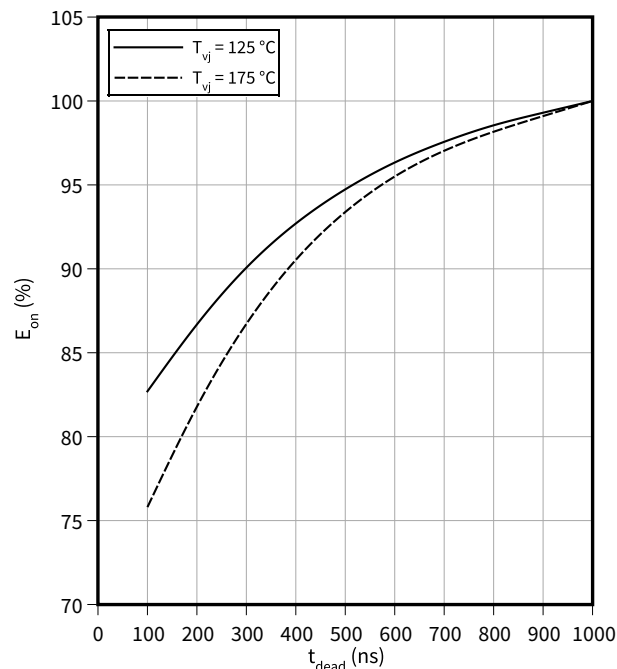
$$E_{on} = f(V_{GS(off)})$$

$R_{Goff} = 2.7 \Omega$, $V_{DD} = 800 \text{ V}$, $R_{Gon} = 10 \Omega$, $V_{GS(on)} = 18 \text{ V}$, $I_D = 75 \text{ A}$, $R_{Gon,o} = 1 \Omega$, $T_{vj} = 175 \text{ }^\circ\text{C}$

开关损耗 (典型), MOSFET, T₁ / T₂

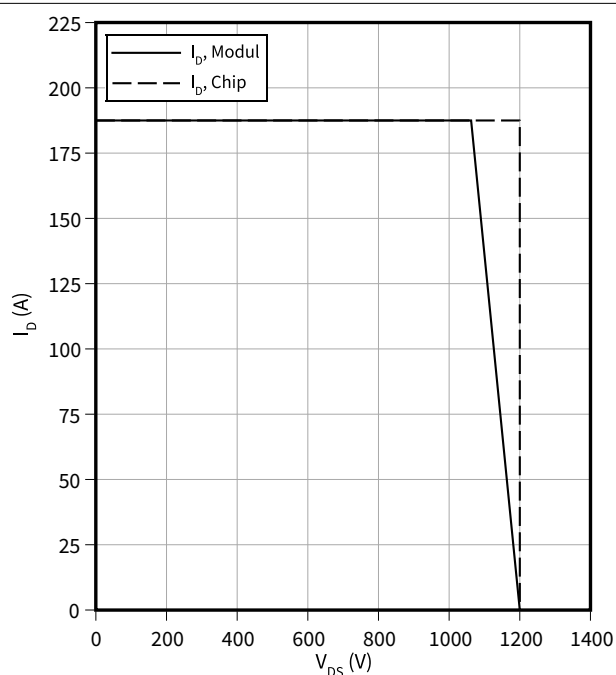
$$E_{on} = f(t_{dead})$$

$R_{Gon} = 10 \Omega$, $I_D = 75 \text{ A}$, $V_{DD} = 800 \text{ V}$, $V_{GS} = -3/18 \text{ V}$

反偏安全工作区 (RBSOA), MOSFET, T₁ / T₂

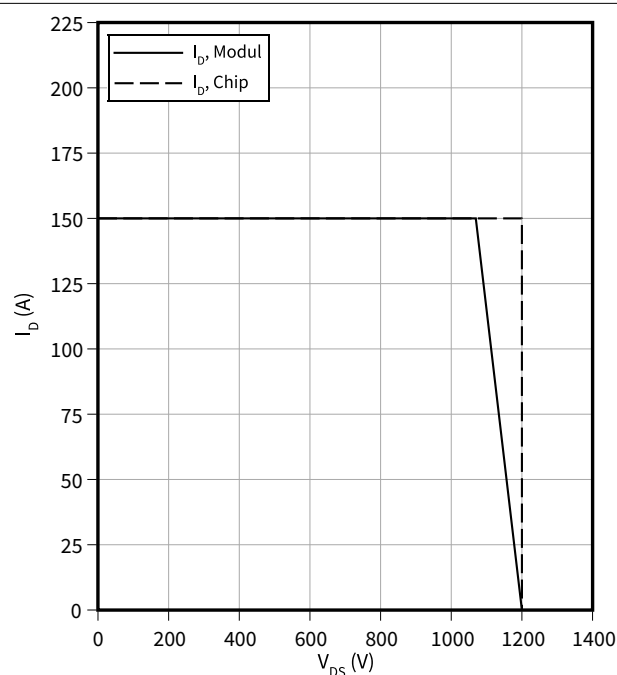
$$I_D = f(V_{DS})$$

$R_{Goff} = 3.3 \Omega$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$

Reverse bias safe operating area (RBSOA), MOSFET, T₁ / T₂

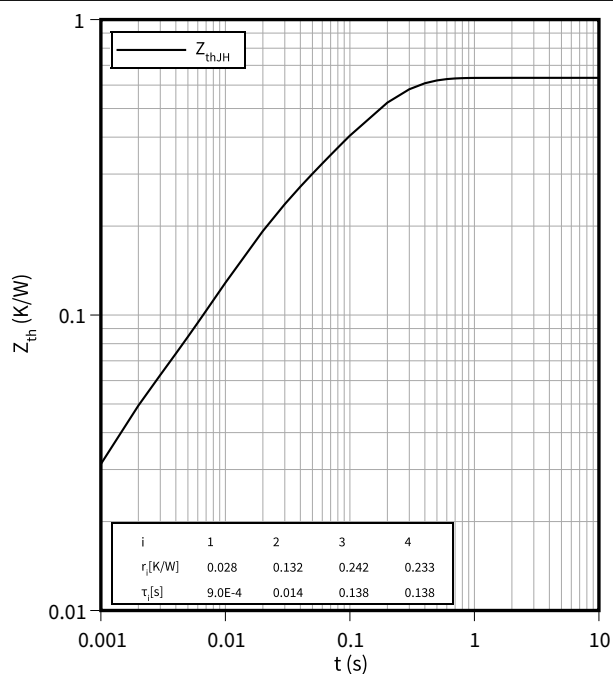
$$I_D = f(V_{DS})$$

$R_{Goff} = 2.7 \Omega$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



瞬态热阻抗, MOSFET, T1 / T2

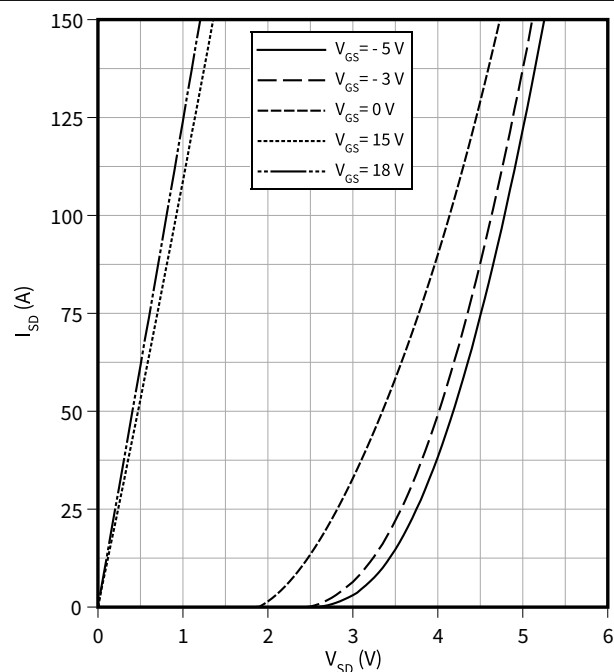
$$Z_{th} = f(t)$$



正向特性 体二极管 (典型), MOSFET, T1 / T2

$$I_{SD} = f(V_{SD})$$

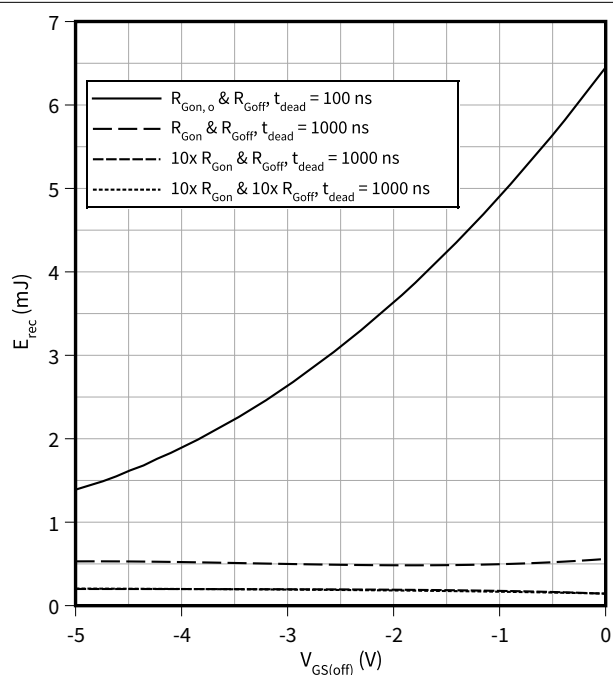
$$T_{vj} = 25^\circ\text{C}$$



开关损耗 体二极管 (典型), MOSFET, T1 / T2

$$E_{rec} = f(V_{GS(off)})$$

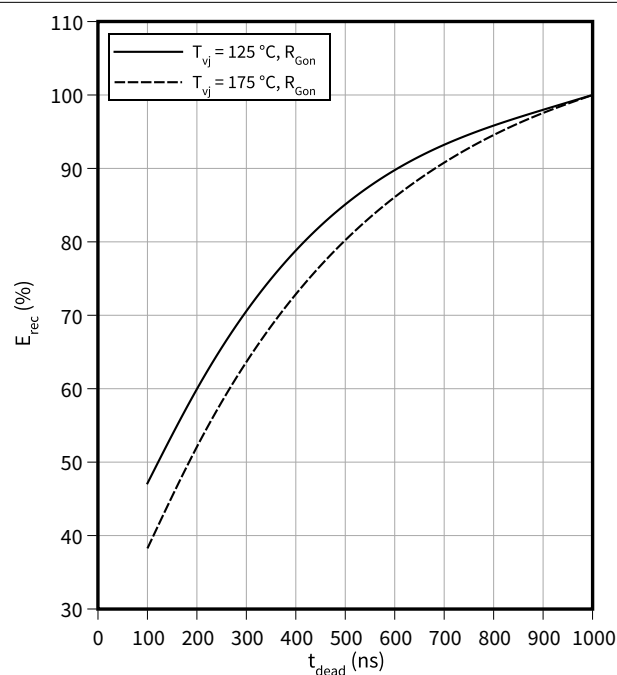
$$R_{Goff} = 2.7\ \Omega, R_{Gon} = 10\ \Omega, V_{GS(on)} = 18\ \text{V}, I_{SD} = 75\ \text{A}, R_{Gon,o} = 1\ \Omega, V_{DD} = 800\ \text{V}, T_{vj} = 175^\circ\text{C}$$



开关损耗 体二极管 (典型), MOSFET, T1 / T2

$$E_{rec} = f(t_{dead})$$

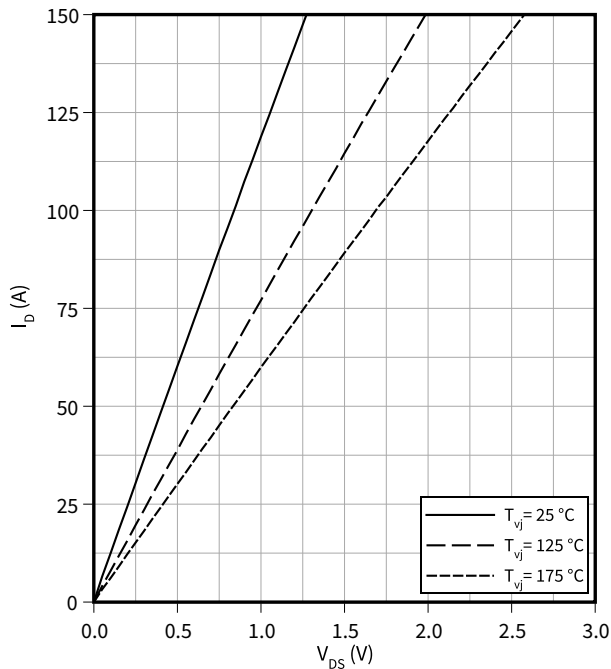
$$R_{Gon} = 10\ \Omega, I_D = 75\ \text{A}, V_{DD} = 800\ \text{V}, V_{GS} = -3/18\ \text{V}$$



7 特征参数图表

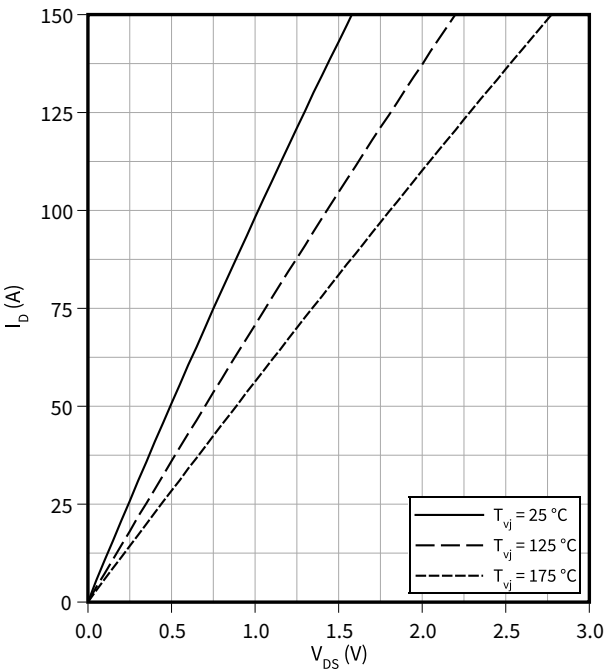
输出特性（典型）, MOSFET, T3 / T4

$I_D = f(V_{DS})$
 $V_{GS} = 18\text{ V}$



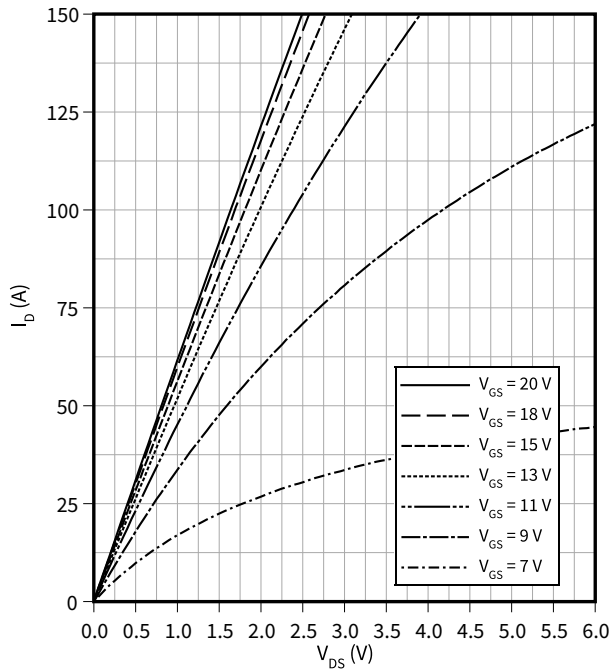
输出特性（典型）, MOSFET, T3 / T4

$I_D = f(V_{DS})$
 $V_{GS} = 15\text{ V}$



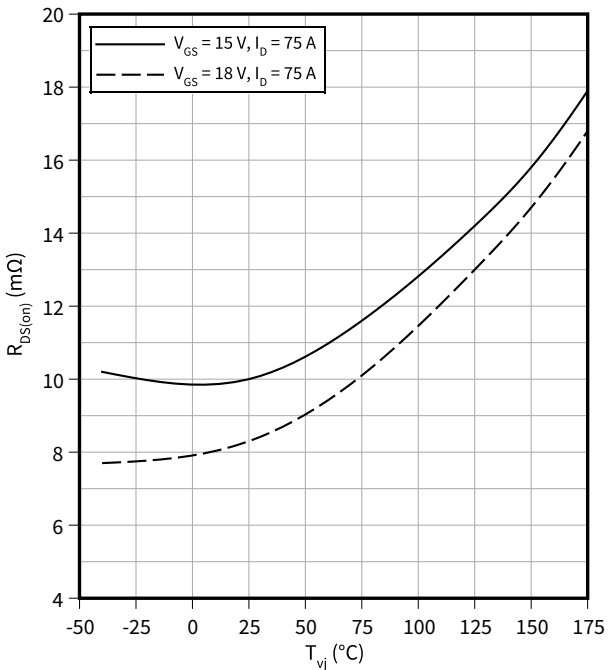
输出特性（典型）, MOSFET, T3 / T4

$I_D = f(V_{DS})$
 $T_{vj} = 175\text{ °C}$



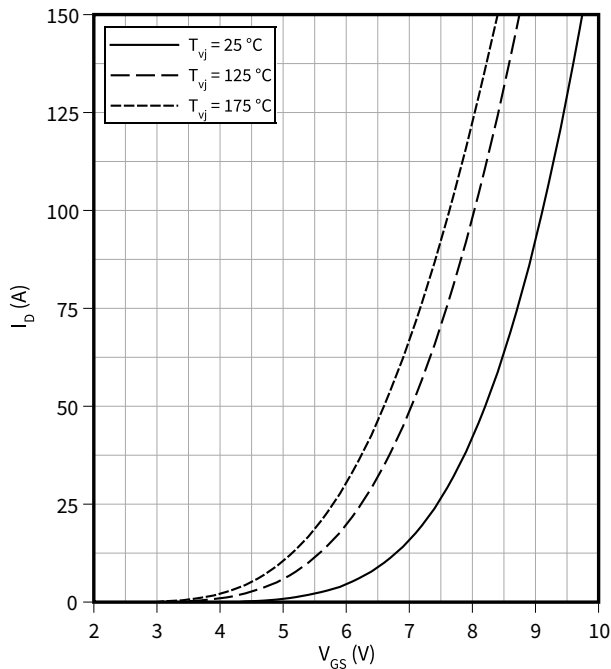
漏源通态电阻（典型）, MOSFET, T3 / T4

$R_{DS(on)} = f(T_{vj})$



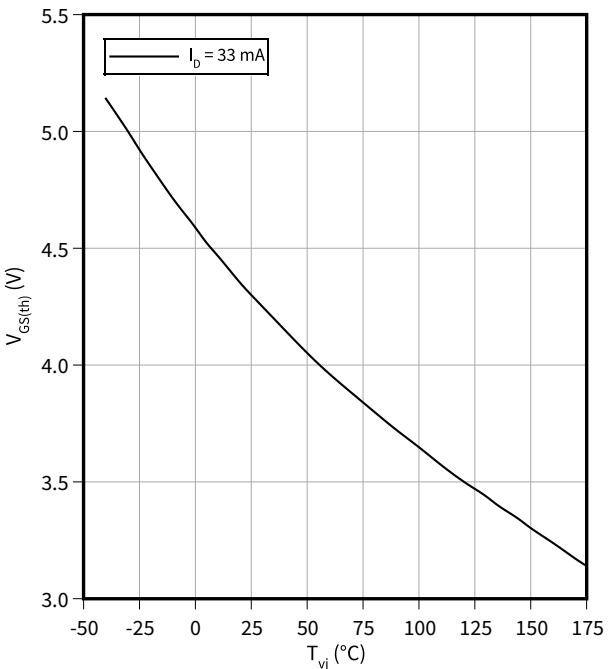
传输特性（典型）, MOSFET, T3 / T4

$I_D = f(V_{GS})$
 $V_{DS} = 20\text{ V}$



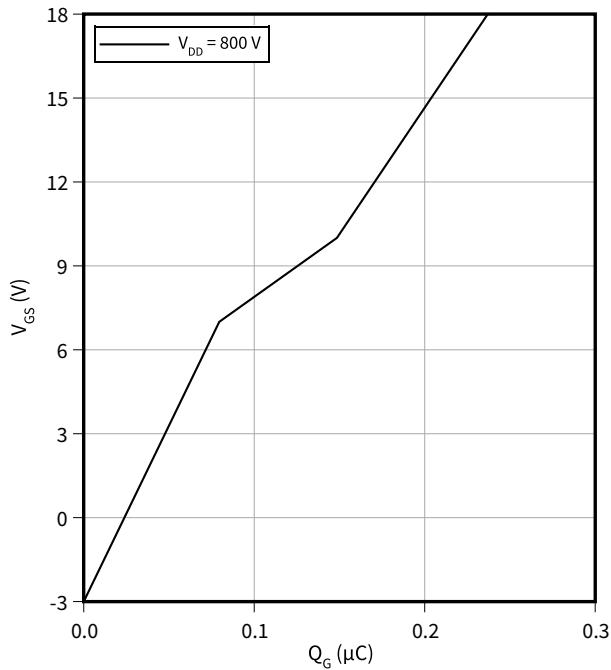
栅-源阈值电压（典型）, MOSFET, T3 / T4

$V_{GS(th)} = f(T_{vj})$
 $V_{GS} = V_{DS}$



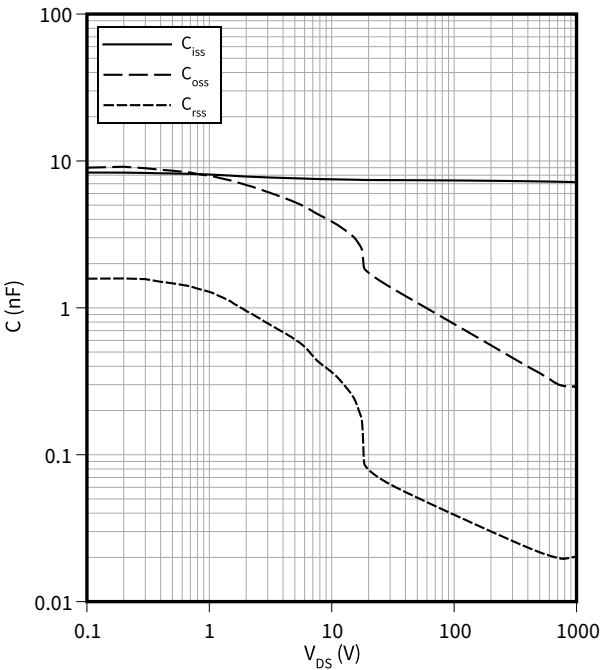
栅极电荷特性（典型）, MOSFET, T3 / T4

$V_{GS} = f(Q_G)$
 $I_D = 75\text{ A}, T_{vj} = 25\text{ °C}$



电容特性（典型）, MOSFET, T3 / T4

$C = f(V_{DS})$
 $f = 100\text{ kHz}, T_{vj} = 25\text{ °C}, V_{GS} = 0\text{ V}$

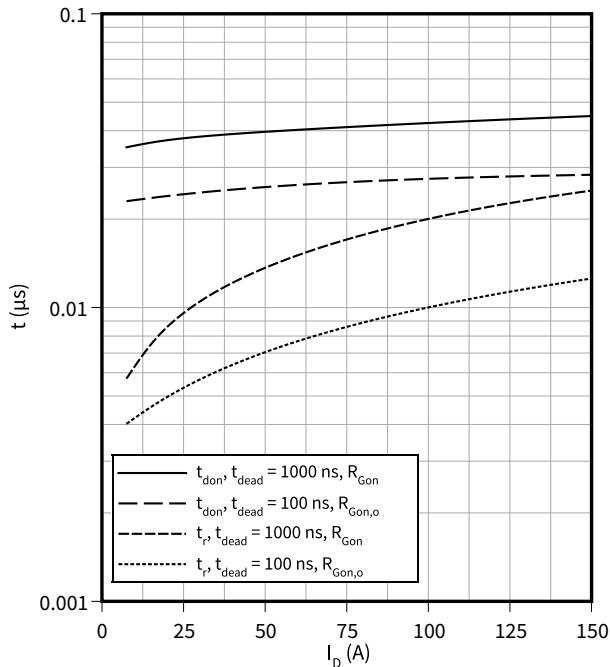


7 特征参数图表

开关时间（典型）, MOSFET, T3 / T4

$t = f(I_D)$

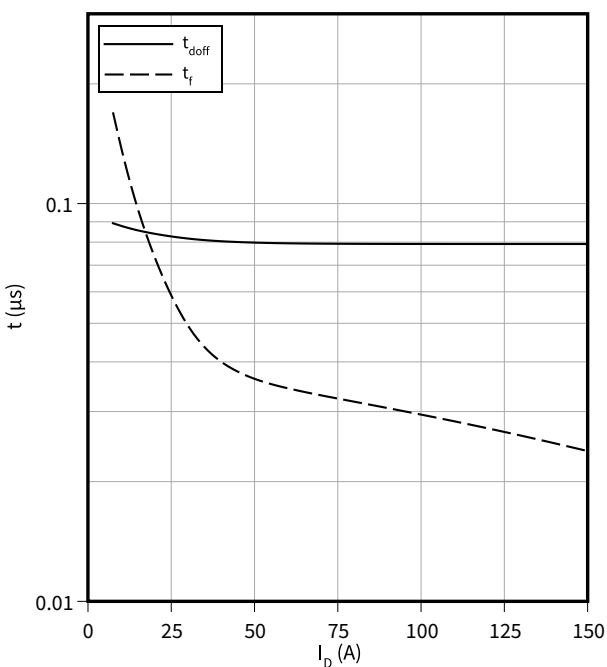
$V_{DD} = 800\text{ V}$, $R_{Gon} = 5.6\ \Omega$, $R_{Gon,o} = 0.0\ \Omega$, $T_{vj} = 175\text{ }^\circ\text{C}$, $V_{GS} = -3/18\text{ V}$



开关时间（典型）, MOSFET, T3 / T4

$t = f(I_D)$

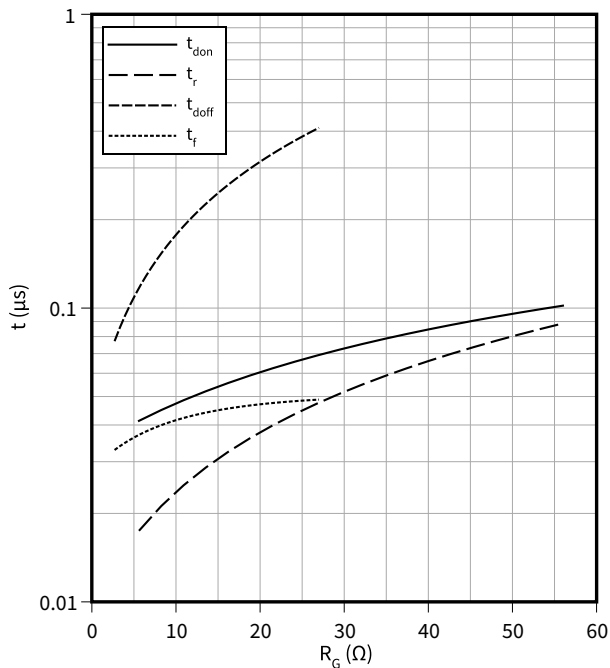
$R_{Goff} = 2.7\ \Omega$, $V_{DD} = 800\text{ V}$, $T_{vj} = 175\text{ }^\circ\text{C}$, $V_{GS} = -3/18\text{ V}$



开关时间（典型）, MOSFET, T3 / T4

$t = f(R_G)$

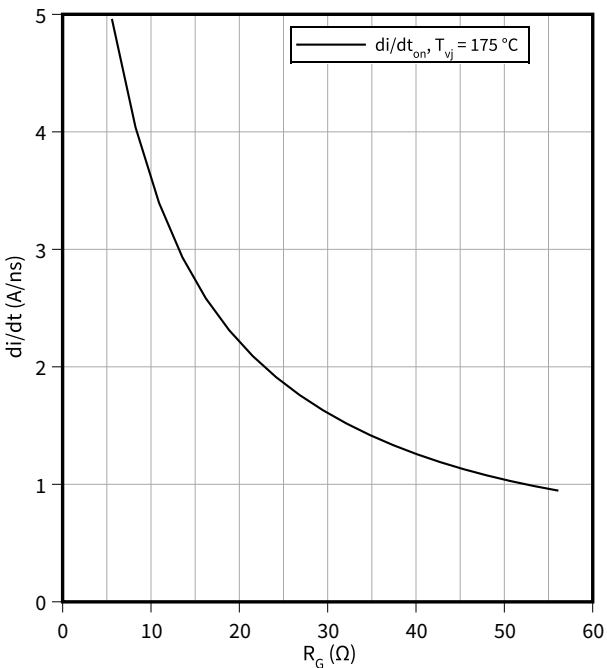
$V_{DD} = 800\text{ V}$, $t_{dead} = 1000\text{ ns}$, $I_D = 75\text{ A}$, $T_{vj} = 175\text{ }^\circ\text{C}$, $V_{GS} = -3/18\text{ V}$



电流变化斜率（典型）, MOSFET, T3 / T4

$di/dt = f(R_G)$

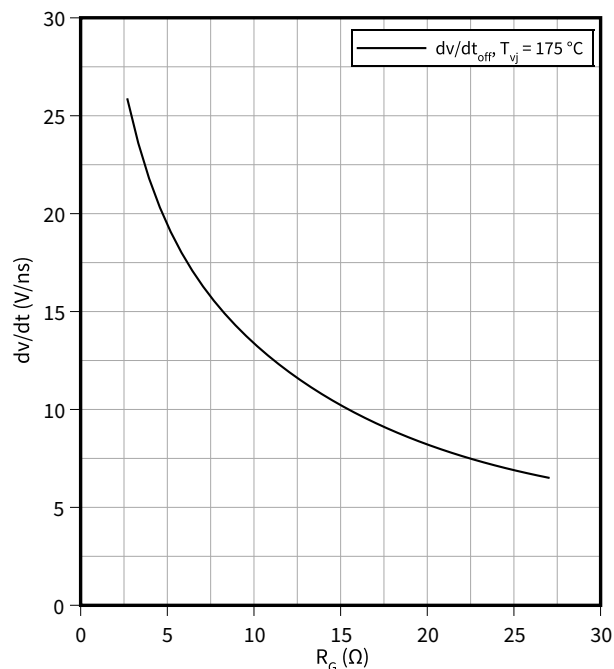
$V_{DD} = 800\text{ V}$, $t_{dead} = 1000\text{ ns}$, $I_D = 75\text{ A}$, $V_{GS} = -3/18\text{ V}$



电压变化斜率 (典型), MOSFET, T3 / T4

$$dv/dt = f(R_G)$$

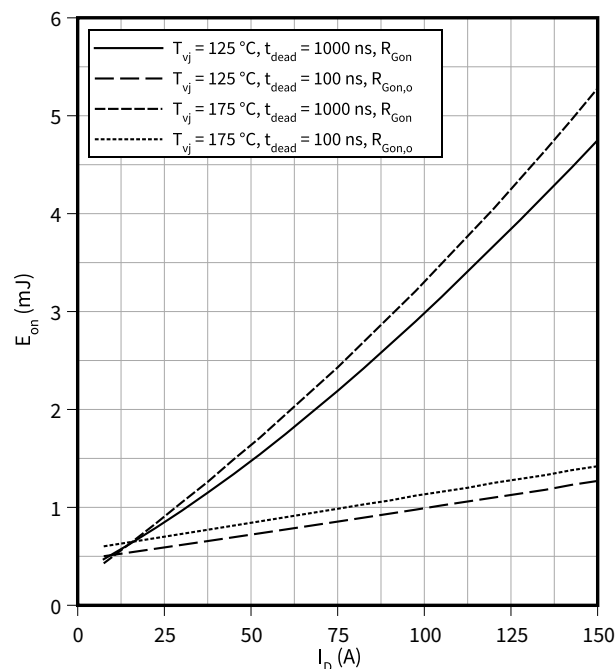
$$V_{DD} = 800 \text{ V}, I_D = 75 \text{ A}, V_{GS} = -3/18 \text{ V}$$



开关损耗 (典型), MOSFET, T3 / T4

$$E_{on} = f(I_D)$$

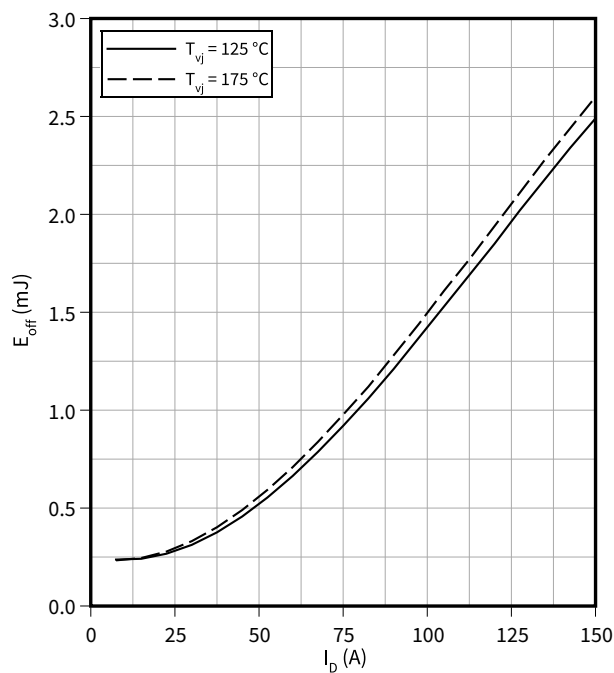
$$V_{DD} = 800 \text{ V}, R_{Gon} = 5.6 \text{ } \Omega, R_{Gon,o} = 0.0 \text{ } \Omega, V_{GS} = -3/18 \text{ V}$$



开关损耗 (典型), MOSFET, T3 / T4

$$E_{off} = f(I_D)$$

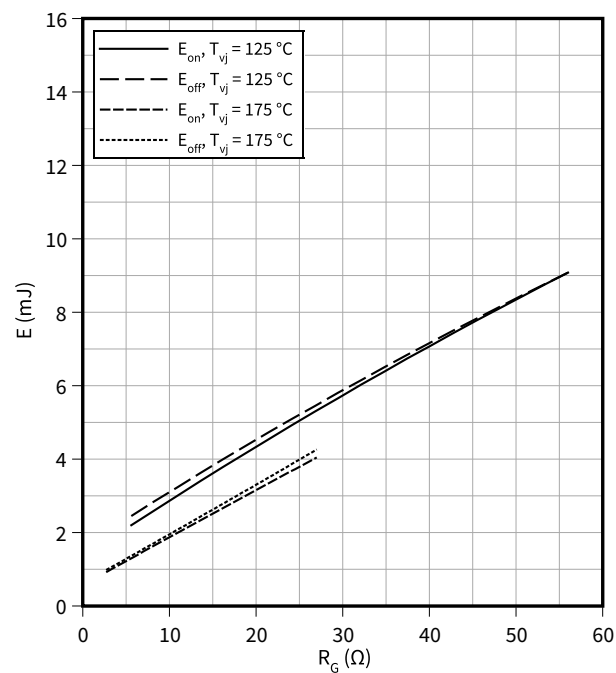
$$R_{Goff} = 2.7 \text{ } \Omega, V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}$$



开关损耗 (典型), MOSFET, T3 / T4

$$E = f(R_G)$$

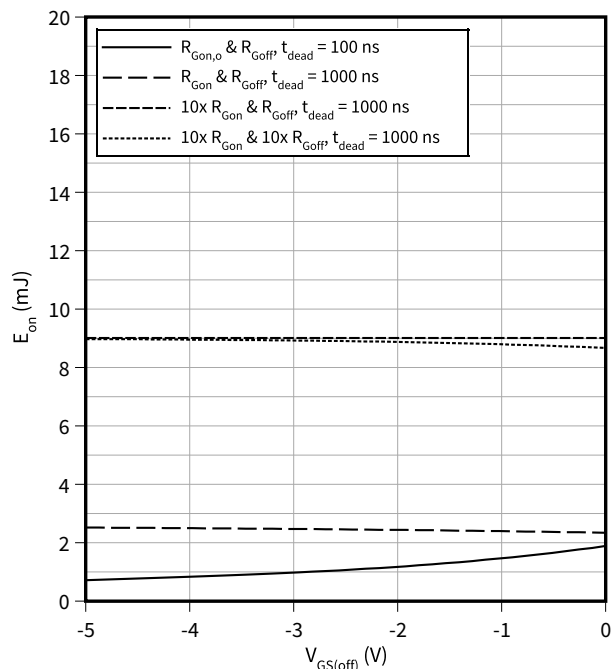
$$V_{DD} = 800 \text{ V}, t_{dead} = 1000 \text{ ns}, I_D = 75 \text{ A}, V_{GS} = -3/18 \text{ V}$$



开关损耗 (典型), MOSFET, T3 / T4

$$E_{on} = f(V_{GS(off)})$$

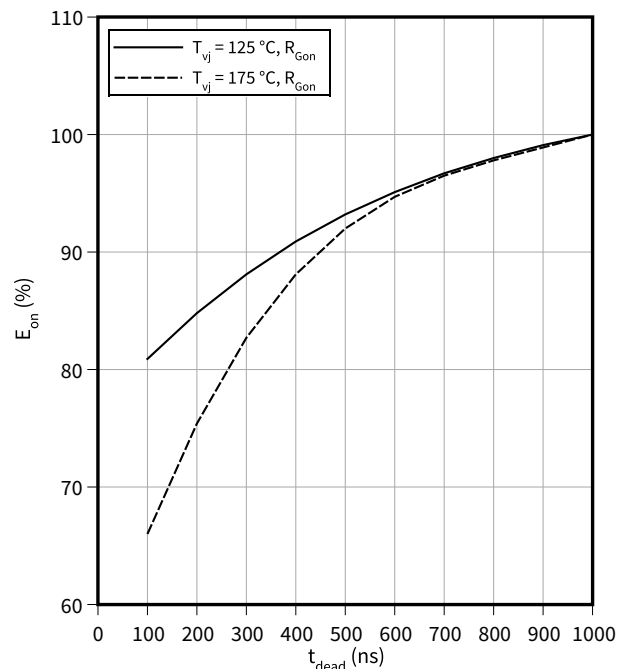
$R_{Goff} = 2.7 \Omega$, $V_{DD} = 800 \text{ V}$, $R_{Gon} = 5.6 \Omega$, $V_{GS(on)} = 18 \text{ V}$, $I_D = 75 \text{ A}$, $R_{Gon,o} = 0.0 \Omega$, $T_{vj} = 175 \text{ }^\circ\text{C}$



开关损耗 (典型), MOSFET, T3 / T4

$$E_{on} = f(t_{dead})$$

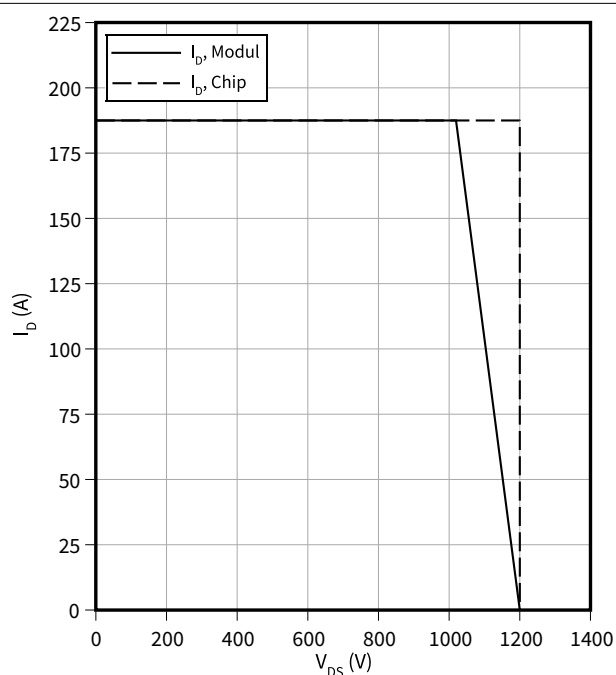
$R_{Gon} = 5.6 \Omega$, $I_D = 75 \text{ A}$, $V_{DD} = 800 \text{ V}$, $V_{GS} = -3/18 \text{ V}$



反偏安全工作区 (RBSOA), MOSFET, T3 / T4

$$I_D = f(V_{DS})$$

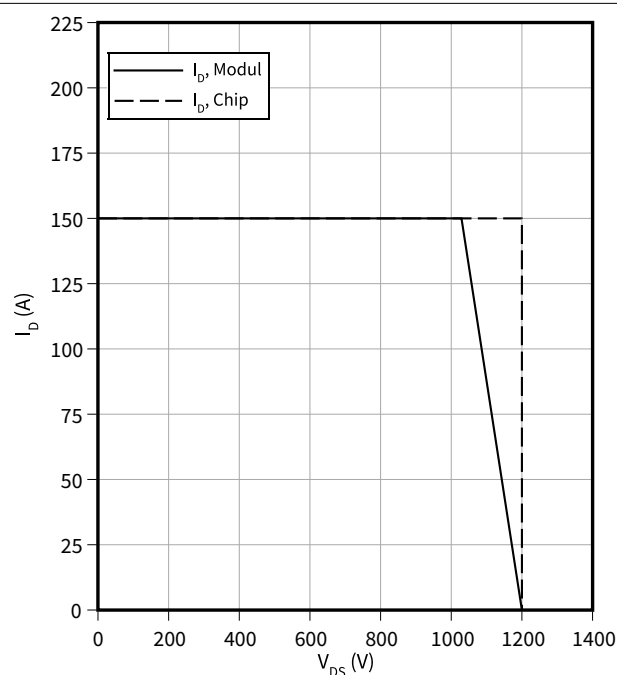
$R_{Goff} = 3.6 \Omega$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



Reverse bias safe operating area (RBSOA), MOSFET, T3 / T4

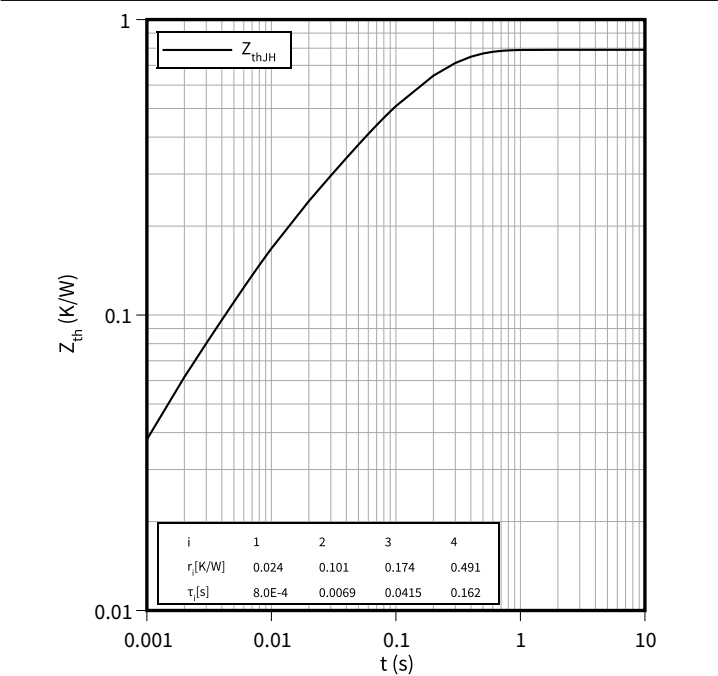
$$I_D = f(V_{DS})$$

$R_{Goff} = 2.7 \Omega$, $T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$



瞬态热阻抗, MOSFET, T3 / T4

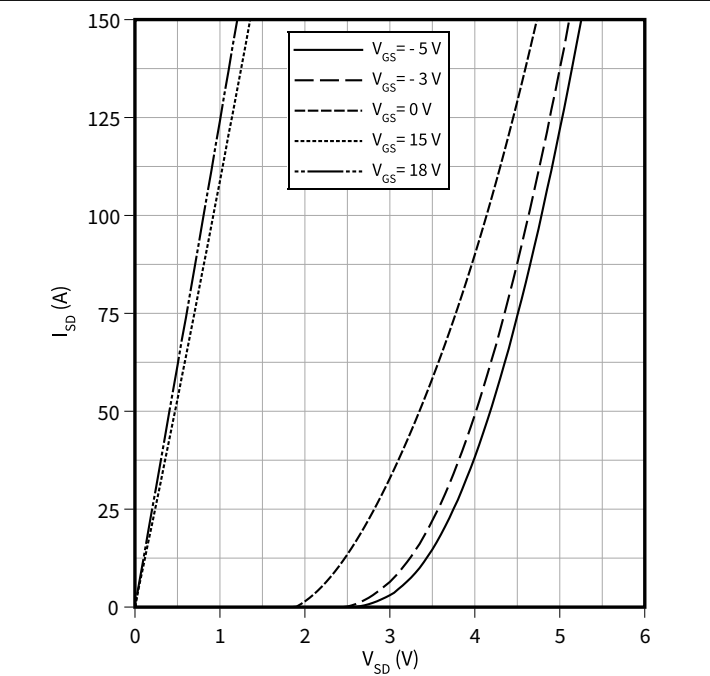
Zth = f(t)



正向特性 体二极管 (典型), MOSFET, T3 / T4

ISD = f(VSD)

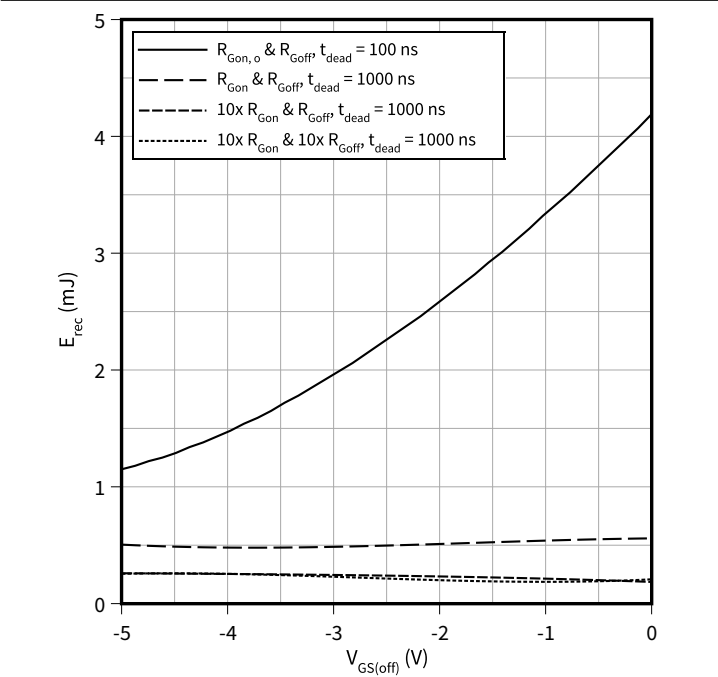
Tvj = 25 °C



开关损耗 体二极管 (典型), MOSFET, T3 / T4

Erec = f(VGS(off))

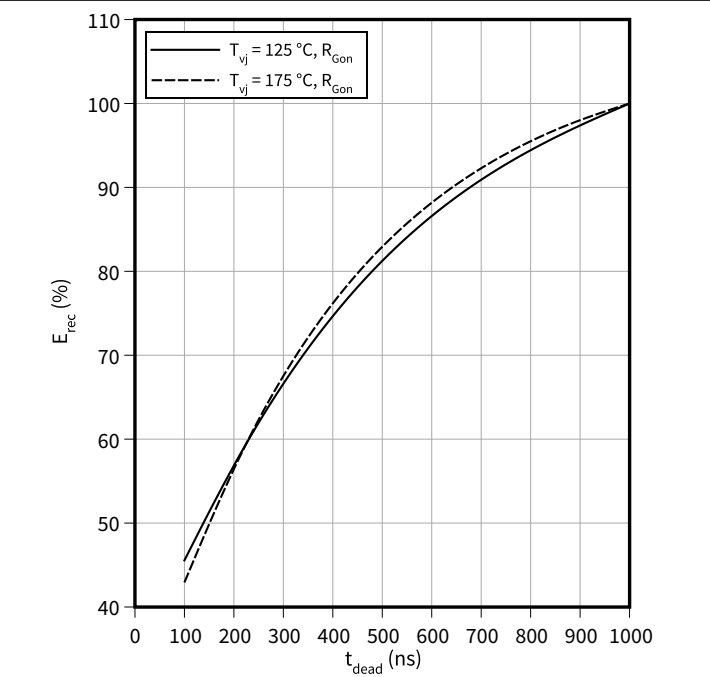
RGoff = 2.7 Ω, RGon = 5.6 Ω, VGS(on) = 18 V, ISD = 75 A, RGon,o = 0 Ω, VDD = 800 V, Tvj = 175 °C



开关损耗 体二极管 (典型), MOSFET, T3 / T4

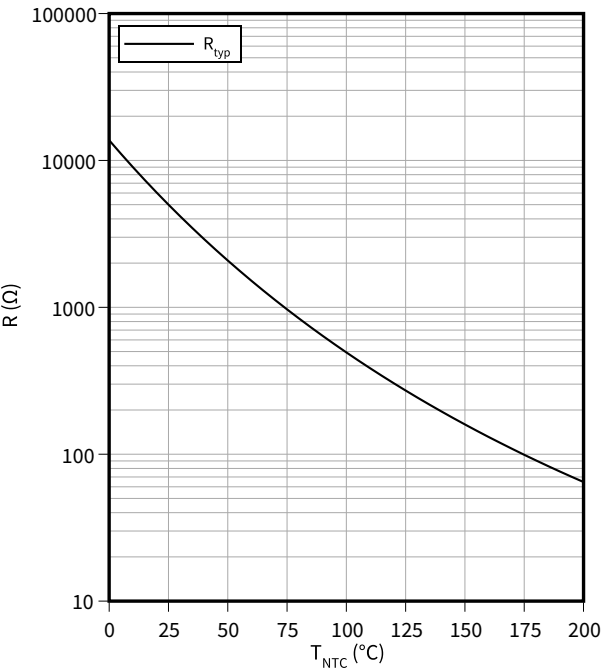
Erec = f(tdead)

RGon = 5.6 Ω, ID = 75 A, VDD = 800 V, VGS = -3/18 V



7 特征参数图表

温度特性, 负温度系数热敏电阻
 $R = f(T_{NTC})$



8 电路拓扑图

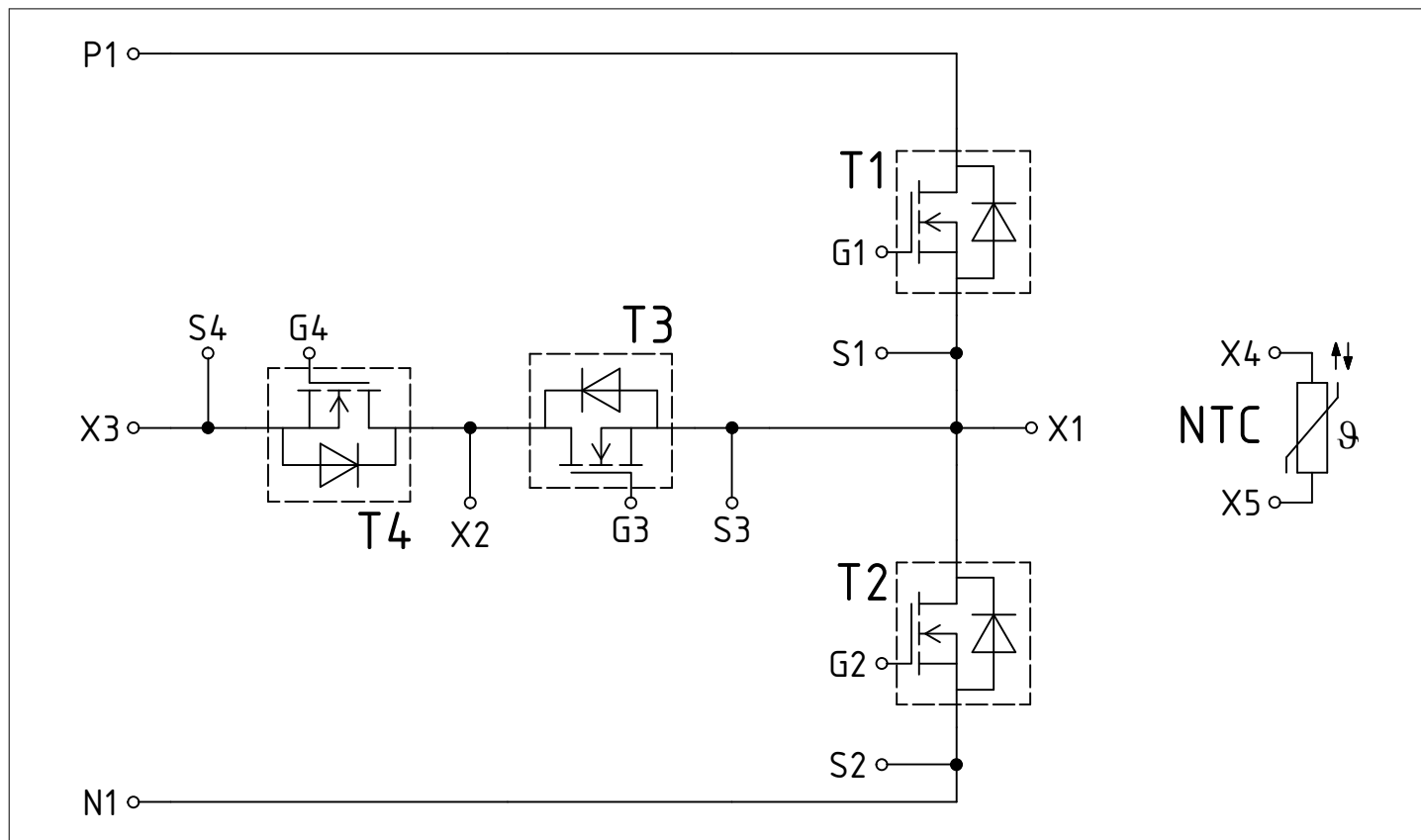


图 1

9 封装尺寸

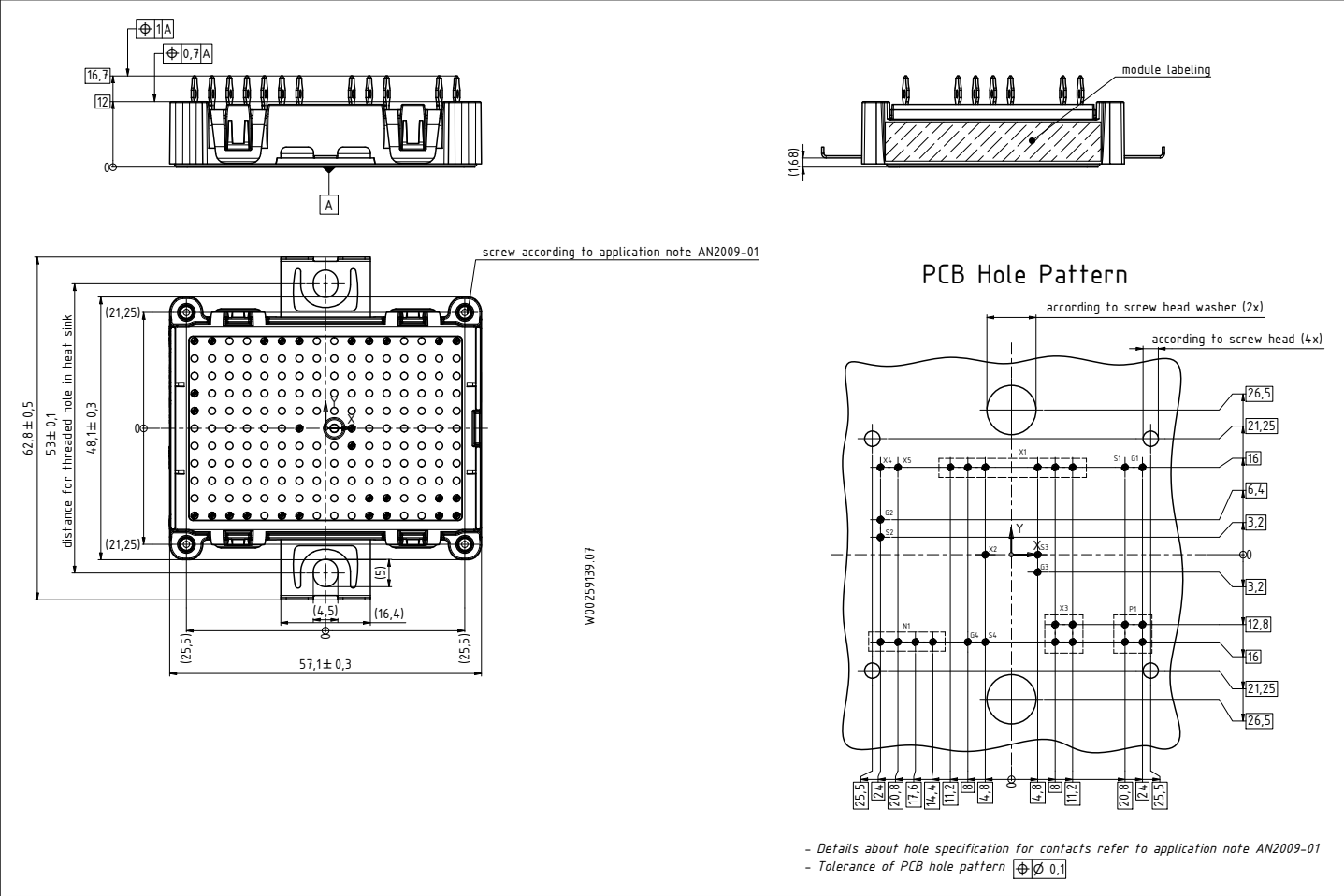


图 2

10 模块标签代码

Module label code			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	Content	Digit	Example
	Module serial number	1 -5	71549
	Module material number	6 - 11	142846
	Production order number	12 - 19	55054991
	Date code (production year)	20 -21	15
	Date code (production week)	22 -23	30
Example	 7154914284655054991153071549142846550549911530		

图 3



修订历史

修订历史

修订版本	发布日期	变更说明
0.10	2025-01-29	Target datasheet
0.20	2025-06-17	Preliminary datasheet

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